

**Search Notes**

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Examiner

Tri V. Nguyen

Applicant(s)/Patent under  
Reexamination

HAITSUKA ET AL.

Art Unit

3622

**SEARCHED**

Class	Subclass	Date	Examiner
705	14	1/23/2006	NVT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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